

Docket No.: P2001,0356

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : TORSTEN SEIDEL ET AL.

Filed : CONCURRENTLY HEREWITH

Title : CONFIGURATION AND METHOD FOR DETECTING DEFECTS
ON A SUBSTRATE IN A PROCESSING TOOL

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

U.S. Patent No. 6,200,823 B1 (Steffan et al.), dated March 13, 2001;

U.S. Patent No. 6,047,083 (Mizuno), dated April 4, 2000;

U.S. Patent No. 5,949,901 (Nichani et al.), dated September 7, 1999;

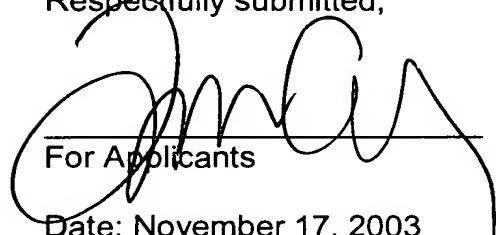
U.S. Patent No. 6,169,282 B1 (Maeda et al.), dated January 2, 2001;

Published European Patent Application No. 0 444 450 A1 (Hopewell et al.), dated September 4, 1991 and

Published International Application No. 98/44330 (Kinney et al.), dated October 8, 1998.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant. As per the Notice in 1273 OG 55 (August 5, 2003) no copies of any above-mentioned U.S. patents and U.S. patent application publications are submitted for any application filed after June 30, 2003..

Respectfully submitted,



For Applicants

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Date: November 17, 2003

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FORM PTO-1449 (SUBSTITUTE)				Attorney Docket No.: P2001,0356 Appl. No.:			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Applicant: TORSTEN SEIDEL ET AL.			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Filing Date: November 17, 2003 Group Art Unit:			

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	6,200,823 B1	03/01	Steffan et al.			
	B	6,047,083	04/00	Mizuno			
	C	5,949,901	09/99	Nichani et al.			
	D	6,169,282 B1	01/01	Maeda et al.			
	E						
	F						
	G						
	H						
	I						

FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	0444450 A1	09/91	Europe			
	K	98/44330	10/98	International			
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	